



Description

JMT N-channel Enhancement Mode Power MOSFET

Features

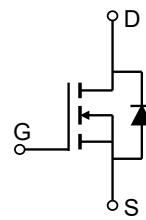
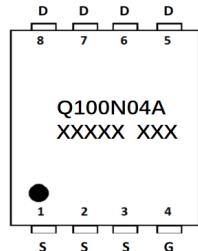
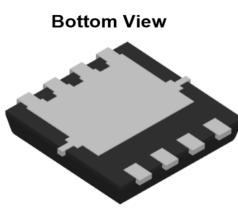
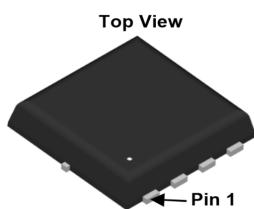
- 40V, 30A
- $R_{DS(ON)} < 11.1\text{m}\Omega @ V_{GS} = 10\text{V}$
- $R_{DS(ON)} < 14.7\text{m}\Omega @ V_{GS} = 4.5\text{V}$
- Advanced Trench Technology
- Excellent $R_{DS(ON)}$ and Low Gate Charge
- Lead Free

Applications

- Load Switch
- PWM Application
- Power Management



100% UIS TESTED!
100% ΔV_{ds} TESTED!



PDFN3x3-8L

Marking and Pin Assignment

Schematic Diagram

Package Marking and Ordering Information

| Device Marking | Device | Outline | Package | Reel Size | Reel(pcs) | Per Carton (pcs) |
|----------------|-------------|---------|------------|-----------|-----------|------------------|
| Q100N04A | JMTQ100N04A | TAPING | PDFN3x3-8L | 13" | 5000 | 50000 |

Absolute Maximum Ratings (@ $T_C = 25^\circ\text{C}$ unless otherwise specified)

| Symbol | Parameter | | Value | Units |
|-----------------|--|---------------------------|------------|---------------------------|
| V_{DS} | Drain-to-Source Voltage | | 40 | V |
| V_{GS} | Gate-to-Source Voltage | | ± 20 | V |
| I_D | Continuous Drain Current | $T_C = 25^\circ\text{C}$ | 30 | A |
| | | $T_C = 100^\circ\text{C}$ | 19 | |
| I_{DM} | Pulsed Drain Current ⁽¹⁾ | | 120 | A |
| E_{AS} | Single Pulsed Avalanche Energy ⁽²⁾ | | 42 | mJ |
| P_D | Power Dissipation | $T_C = 25^\circ\text{C}$ | 26 | W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient ⁽³⁾ | | 43 | $^\circ\text{C}/\text{W}$ |
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case | | 4.8 | |
| T_J, T_{STG} | Junction & Storage Temperature Range | | -55 to 150 | $^\circ\text{C}$ |



JMTQ100N04A

Electrical Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise specified)

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|---|--|--|------|------|-----------|------------------|
| Off Characteristics | | | | | | |
| $V_{(\text{BR})\text{DSS}}$ | Drain-Source Breakdown Voltage | $I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$ | 40 | - | - | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 40\text{V}, V_{GS} = 0\text{V}$ | - | - | 1.0 | μA |
| I_{GSS} | Gate-Body Leakage Current | $V_{DS} = 0\text{V}, V_{GS} = \pm 20\text{V}$ | - | - | ± 100 | nA |
| On Characteristics | | | | | | |
| $V_{GS(\text{th})}$ | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_D = 250\mu\text{A}$ | 1.2 | 1.8 | 2.4 | V |
| $R_{\text{DS(ON)}}$ | Static Drain-Source ON-Resistance ⁽⁴⁾ | $V_{GS} = 10\text{V}, I_D = 30\text{A}$ | - | 8.5 | 11.1 | $\text{m}\Omega$ |
| | | $V_{GS} = 4.5\text{V}, I_D = 20\text{A}$ | - | 11.3 | 14.7 | $\text{m}\Omega$ |
| Dynamic Characteristics | | | | | | |
| C_{iss} | Input Capacitance | $V_{GS} = 0\text{V}, V_{DS} = 20\text{V}, f = 1\text{MHz}$ | - | 1913 | - | pF |
| C_{oss} | Output Capacitance | | - | 125 | - | pF |
| C_{rss} | Reverse Transfer Capacitance | | - | 104 | - | pF |
| Q_g | Total Gate Charge | $V_{GS} = 0 \text{ to } 10\text{V}$ $V_{DS} = 20\text{V}, I_D = 20\text{A}$ | - | 37 | - | nC |
| Q_{gs} | Gate Source Charge | | - | 8 | - | nC |
| Q_{gd} | Gate Drain("Miller") Charge | | - | 7 | - | nC |
| Switching Characteristics | | | | | | |
| $t_{d(on)}$ | Turn-On Delay Time | $V_{GS} = 10\text{V}, V_{DD} = 20\text{V}$ $I_D = 20\text{A}, R_{\text{GEN}} = 3\Omega$ | - | 8 | - | ns |
| t_r | Turn-On Rise Time | | - | 28 | - | ns |
| $t_{d(off)}$ | Turn-Off Delay Time | | - | 36 | - | ns |
| t_f | Turn-Off Fall Time | | - | 6 | - | ns |
| Drain-Source Diode Characteristics and Max Ratings | | | | | | |
| I_S | Maximum Continuous Drain to Source Diode Forward Current | - | - | 30 | A | |
| I_{SM} | Maximum Pulsed Drain to Source Diode Forward Current | - | - | 120 | A | |
| V_{SD} | Drain to Source Diode Forward Voltage | $V_{GS} = 0\text{V}, I_S = 30\text{A}$ | - | - | 1.2 | V |
| trr | Body Diode Reverse Recovery Time | $I_F = 20\text{A}, di/dt = 100\text{A/us}$ | - | 10 | - | ns |
| Qrr | Body Diode Reverse Recovery Charge | | - | 5 | - | nC |

Notes:

1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

2. E_{AS} condition: Starting $T_J = 25^\circ\text{C}$, $V_{DD} = 20\text{V}$, $V_G = 10\text{V}$, $R_G = 25\text{ohm}$, $L = 0.5\text{mH}$, $I_{AS} = 13\text{A}$ 3. $R_{\theta JA}$ is measured with the device mounted on a 1inch² pad of 2oz copper FR4 PCB4. Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 0.5\%$.

Typical Performance Characteristics

Figure 1: Output Characteristics

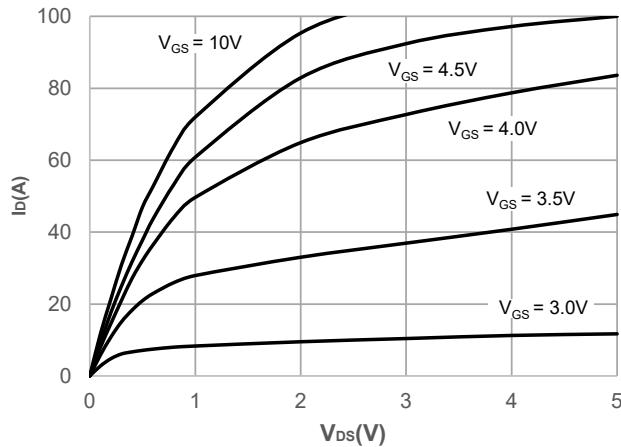


Figure 2: Typical Transfer Characteristics

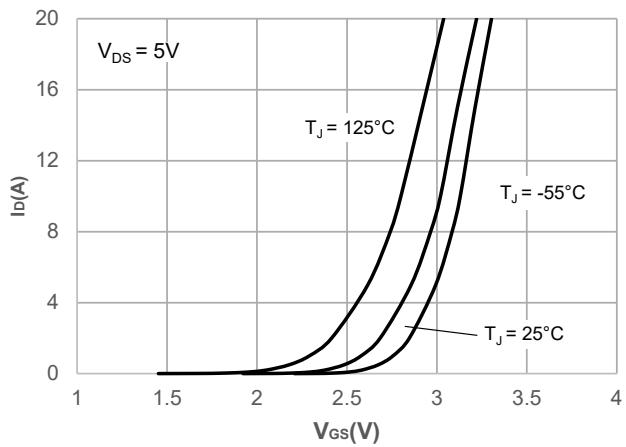


Figure 3: On-resistance vs. Drain Current

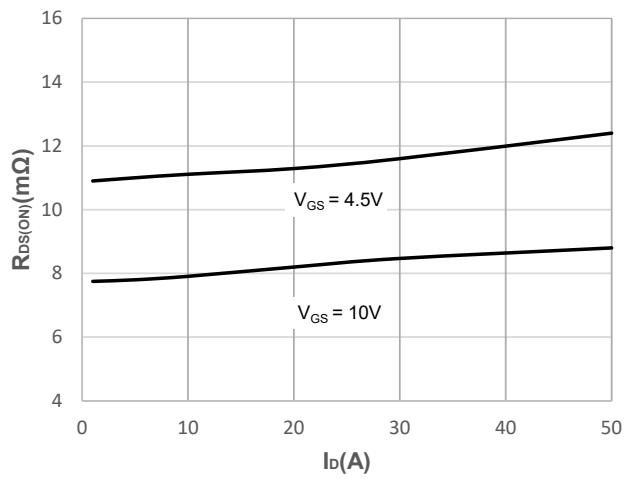


Figure 4: Body Diode Characteristics

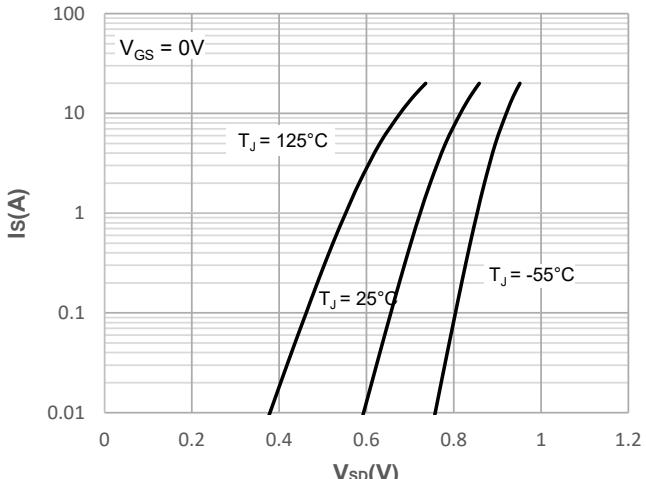


Figure 5: Gate Charge Characteristics

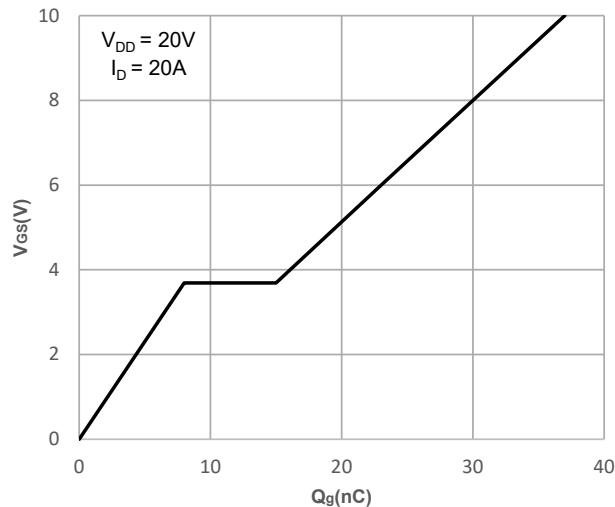
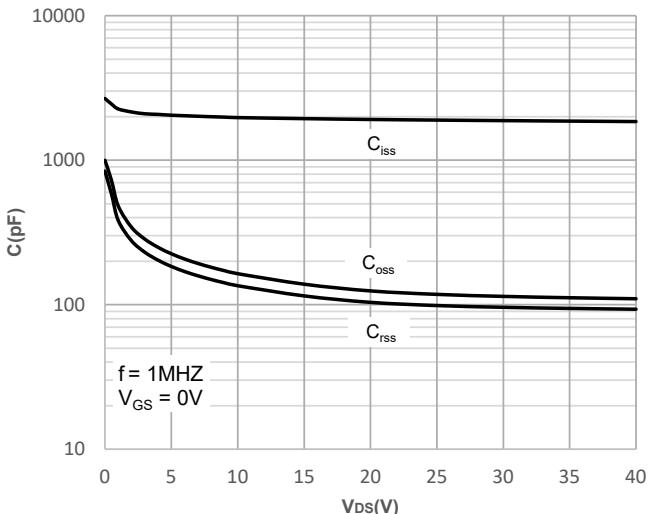


Figure 6: Capacitance Characteristics



Typical Performance Characteristics

Figure 7: Normalized Breakdown voltage vs. Junction Temperature

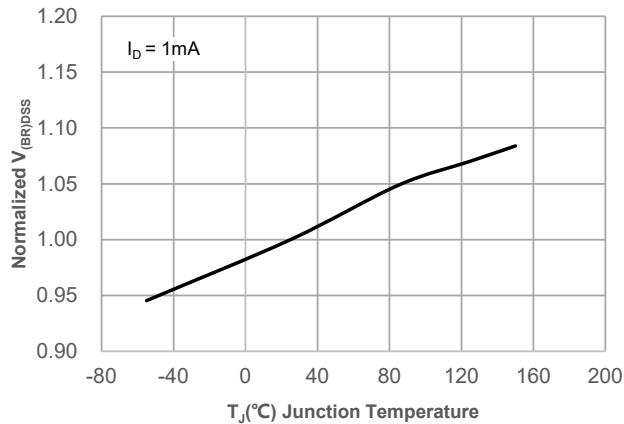


Figure 8: Normalized on Resistance vs. Junction Temperature

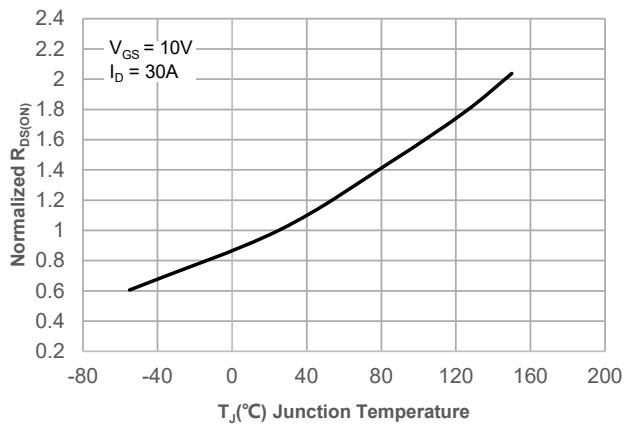


Figure 9: Maximum Safe Operating Area

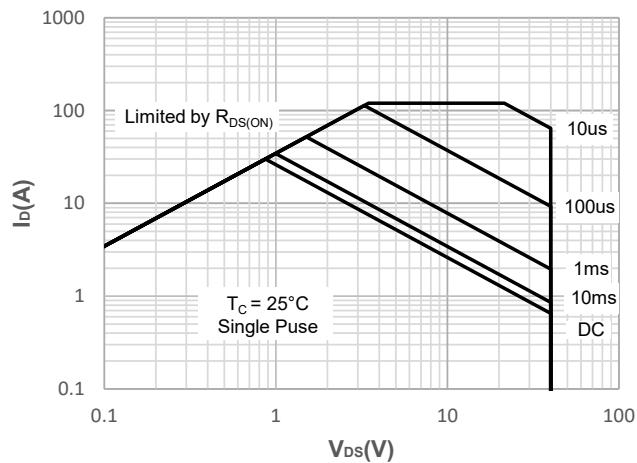


Figure 10: Maximum Continuous Drian Current vs. Case Temperature

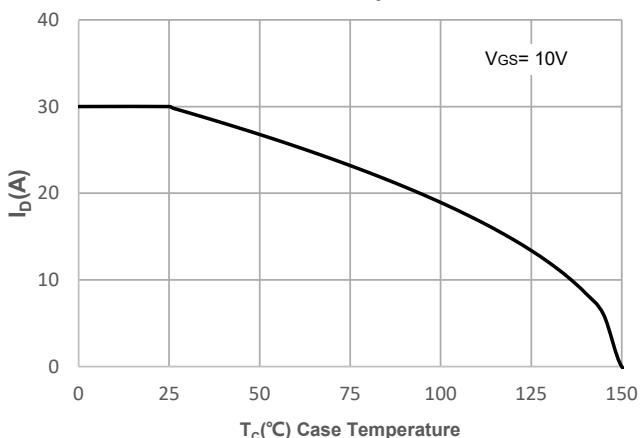


Figure 11: Normalized Maximum Transient Thermal Impedance

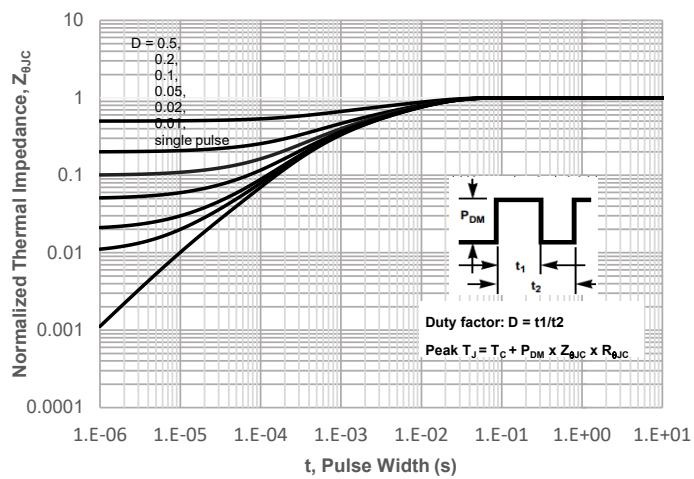
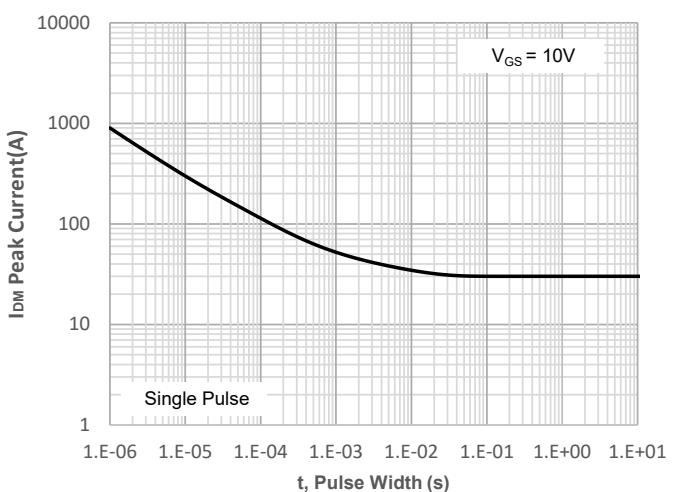


Figure 12: Peak Current Capacity



Test Circuit

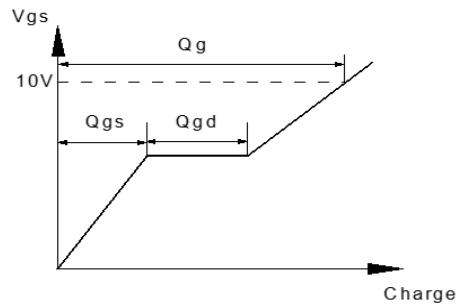
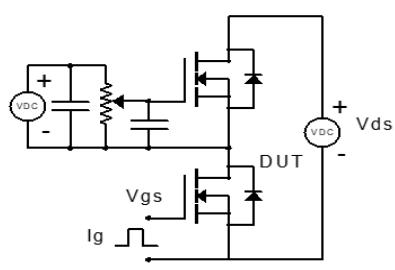


Figure 1: Gate Charge Test Circuit & Waveform

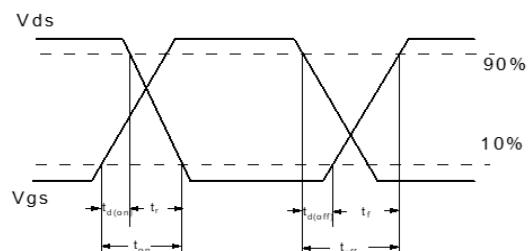
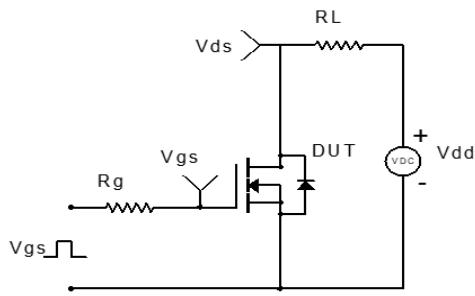


Figure 2: Resistive Switching Test Circuit & Waveform

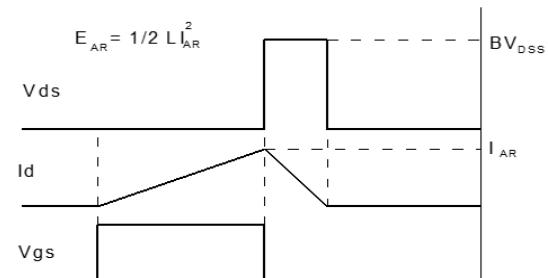
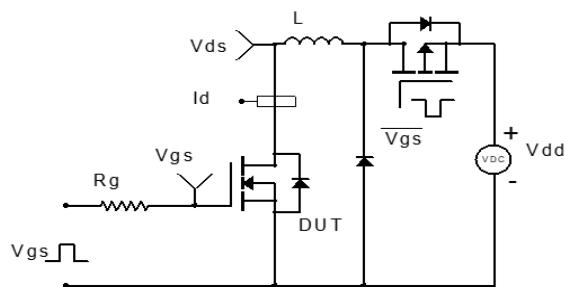


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

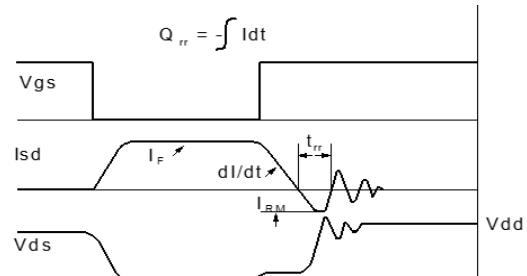
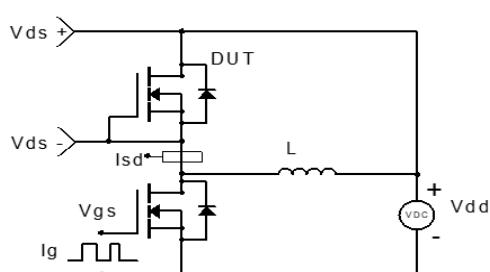
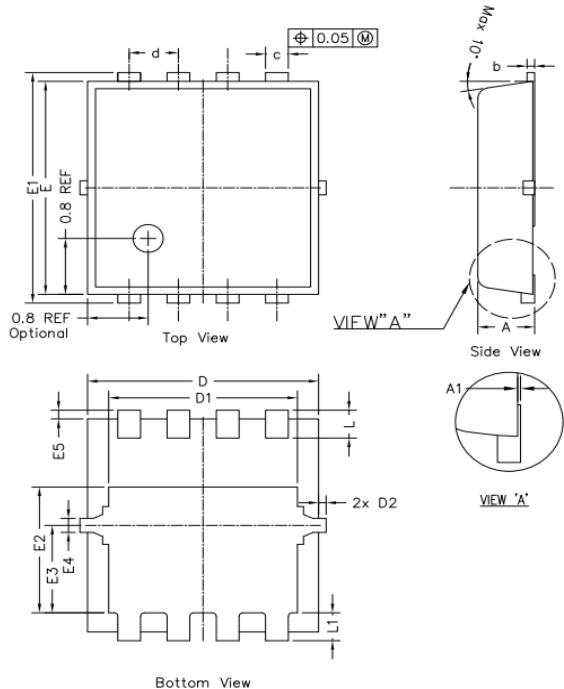


Figure 4: Diode Recovery Test Circuit & Waveform

Package Mechanical Data(PDFN3x3-8L)



| SYMBOLS | DIMENSION IN MM | | | DIMENSION IN INCHES | | |
|---------|-----------------|-------|-------|---------------------|-------|-------|
| | MIN | NOM | MAX | MIN | NOM | MAX |
| A | 0.700 | 0.750 | 0.800 | 0.028 | 0.030 | 0.031 |
| A1 | --- | --- | 0.050 | ---- | ---- | 0.002 |
| b | 0.144 | 0.152 | 0.202 | 0.006 | 0.006 | 0.008 |
| c | 0.250 | 0.300 | 0.350 | 0.010 | 0.012 | 0.014 |
| d | 0.65 BSC | | | 0.026 BSC | | |
| D | 2.950 | 3.050 | 3.150 | 0.116 | 0.120 | 0.124 |
| D1 | 2.390 | 2.490 | 2.590 | 0.094 | 0.098 | 0.102 |
| D2 | --- | --- | 0.125 | --- | --- | 0.005 |
| E | 2.950 | 3.050 | 3.150 | 0.116 | 0.120 | 0.124 |
| E1 | 3.200 | 3.300 | 3.400 | 0.126 | 0.130 | 0.134 |
| E2 | 1.700 | 1.800 | 1.900 | 0.067 | 0.071 | 0.075 |
| E3 | 1.150 | 1.250 | 1.350 | 0.045 | 0.049 | 0.053 |
| E4 | 0.150 | 0.200 | 0.250 | 0.006 | 0.008 | 0.010 |
| E5 | 0.075 | 0.125 | 0.175 | 0.003 | 0.005 | 0.007 |
| L | 0.300 | 0.400 | 0.500 | 0.01 | 0.02 | 0.02 |
| L1 | 0.300 | 0.400 | 0.500 | 0.01 | 0.02 | 0.02 |

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